

Data sheet acquired from Harris Semiconductor SCHS063B – Revised July 2003

CD4094B Types

CMOS 8-Stage Shift-and-Store **Bus Register**

High-Voltage Types (20-Volt Rating)

■ CD4094B is an 8-stage serial shift register having a storage latch associated with each stage for strobing data from the serial input to parallel buffered 3-state outputs. The parallel outputs may be connected directly to common bus lines. Data is shifted on positive clock transitions. The data in each shift register stage is transferred to the storage register when the STROBE input is high. Data in the storage register appears at the outputs whenever the OUTPUT-ENABLE signal is high.

Two serial outputs are available for cascading a number of CD4094B devices. Data is available at the OS serial output terminal on positive clock edges to allow for high-speed operation in cascaded systems in which the clock rise time is fast. The same serial information, available at the Ω'_S terminal on the next negative clock edge, provides a means for cascading CD4094B devices when the clock rise time is slow.

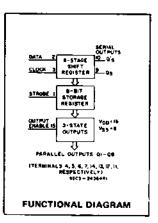
The CD4094B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

Features:

- 3-state parallel outputs for connection to common bus
- Separate serial outputs synchronous to both positive and negative clock edges for cascading
- Medium speed operation 5 MHz at 10 V (typ.)
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package temperature range): 1 V at V_{DD} = 5 V 2 V : 2.5 V at V_{DD} = 15 V 2 V at V_{DD} = 10 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices'

Applications:

- Serial-to-parallel data conversion
- Remote control holding register
- Dual-rank shift, hold, and bus applications



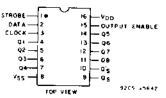
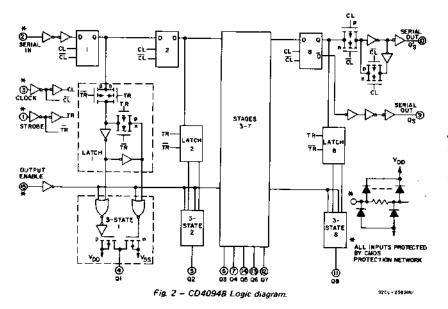


Fig. 1 - Terminal assignment.

MAXIMUM RATINGS, Absolute-Maximum Values:

	DC SUPPLY-VOLTAGE RANGE, (VDD)
	Voltages referenced to VSS Terminal)
	INPUT VOLTAGE RANGE, ALL INPUTS
±10mA	DC INPUT CURRENT, ANY ONE INPUT
	POWER DISSIPATION PER PACKAGE (PD):
500mW	For TA = -55°C to +100°C
Derate Linearity at 12mW/OC to 200mW	For T _A = +100°C to +125°C
,	DEVICE DISSIPATION PER OUTPUT TRANSISTOR
Types)	FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package
-55°C to +125°C	OPERATING-TEMPERATURE RANGE (TA)
65°C to +150°C	STORAGE TEMPERATURE HANGE (Talg)
	LEAD TEMPERATURE (DURING SOLDERING):
av	Al distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s m



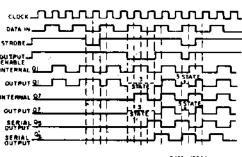


Fig. 3 - Timing diagram,

RECOMMENDED OPERATING CONDITIONS at TA = 25°C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

ALLA C. A. A.T.C. LIATIO	VDD	Life		
CHARACTERISTIC	(V)	MIN.	MAX.	UNITS
Supply-Voltage Range (For TA=Full Package-Temperature Range)		3	18	v
· .	5	125	-	
Data Setup Time, ts	10	55	-	ns
	15	35	-	
	5	200	_	
Clock Pulse Width, tw	10	100	1 +	ns
·	15	83	-	
	5		1.25	
Clock Input Frequency, fCL	10	dc	2.5	MHz
	15		18 1.25	
Clock Input Rise or Fall time,	5	1	15	<u> </u>
t _r CL, t _f CL:*	10 15		5	μs
	5	200	-	
Strobe Pulse Width, tw	10	80	-	ns
	15	70	-	

^{*}If more than one unit is cascaded toCL (for Q5 only) should be made less than or equal to the sum of the fixed propagation delay at 50 pF and the transition time of the output driving stage for the estimated capacitive load.

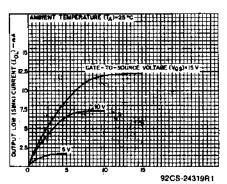


Fig. 5 - Minimum output low (sink) current characteristics.

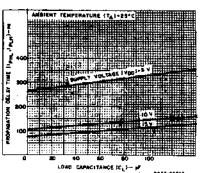
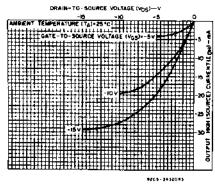
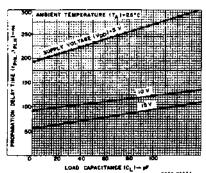


Fig. 8 — Clock-to-serial output Q_S propagation datasets C. delay vs C_L .



CD4094B Types

Fig. 6 - Typical output high (source) current characteristics.



- Clock-to-serial output Q'S propagation delay vs C_L.

ÇL.ª	Output	Strobe	Dete		raliei riputs		riel puts
ŲL.	Enable	21700	D#0#	Q1	ON	O3-	0.2
7	0	х	х	ОС	ос	Q7	NC
~	0	*	х	QC	ОC	NC	Q7
	. 1	o	x	N€	NC	07	NC
	1	ı	0	0	ON-1	07	NC
	1	,	7	1	Q _{N-I}	07	NC
~	1	,	1	NC	NC	NC	Q7

TRUTH TARKE

4 - Lavel Change X = Don't Care NC = No Change

Logic 1 ≠ High Logic 0 = Law

OC = Open Circuit

At the positive clock edge information in the 7th shift register stage is transferred to the 8th register stage and the OS output.

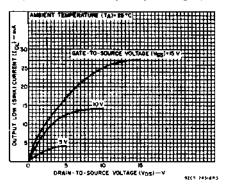


Fig. 4 - Typical output low (sink) current characteristics.

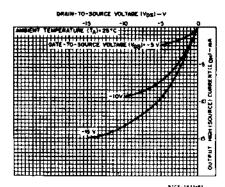


Fig. 7 - Minimum output high (source) current characterístics.

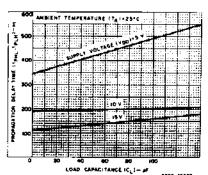


Fig. 10 - Clock-to-parallel output propagation delay vs C_L .

CD4094B Types

STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CONE	OITIO	is :	MI	LIMITS AT INDICATED TEMPERATURES (°C)						
ISTIC	٧o	VIN	VDD	· [+25			UNITS
.*	(8)	(V)	(8)	-55	-40	+85	+125	Min.	Тур.	Max.	
Quiescent Device		0,5	5	5	5	150	150	-	0.04	. 5	
Current,		0,10	10	10	10	300	300	-	0.04	-10	
IDD Max.	-	0,15	15	20	20	600	600	-	0.04	20	.μΑ
		0,20	20	100	100	3000	3000	- '	0.08	100	·
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1	-	
(Sink) Current	0,5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-	
Output High (Source) Current,	1.5	0,15	15	4.2	4	2.8	2,4	34	6.8	-	
	4.6	0,5	5	-0,64	-0.61	-0.42	- D.36	-0.51	-1	-	mA
	2.5	0,5	5	-2	-1.8	-1.3	- 1.15	-1.6	-3.2		
	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	- 1.3	-2.6		
TOH WITT	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8		l
Output Voltage:	· –	0,5	5		0	.05 -		-	o	0.05	
Low-Level,	^	0,10	10		0	.05			0	0.05	1 .
VOL Max.	-	0.15	15		ő	.05		- 1	Ö	0.05	v
Output Voltage:	-	0,5	5		4	.95		4.95	5	-	ľ
High Level,		0,10	10		9	.95		9.95	10	-	
VOH Min.	_	0,15	15		14	1.95		14.95	15	-	i
Input Low	0.5, 4.5	-	5		1	.5				1.5	
Voltage,	1, 9	_	10			3		_	-	3	
V _{IL} Max.	1.5,13.5	_	15			4		_		4	i
Input High	0.5, 4.5	·-	5		;	3.5		3.5	_		V
Voltage,	1, 9		10			7		-7			
VIH Min.	1.5,13.5	-	15			11		11	_	_	
Input Current I(N Max.	-	0,18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μΑ
3-State Output Leakage Current FOUT Max.	0,18	0,18	18	±0.4	±0.4	±12	±12		+10- 4	±0.4	μΑ

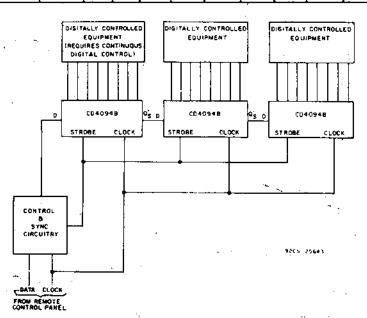


Fig. 14 - Remote control holding register.

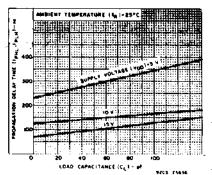


Fig. 11 - Strobe-to-parallel output propagation delay vs C_L.

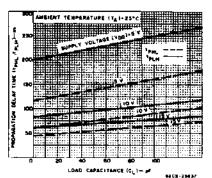


Fig. 12 — Output enable-to-parallel output propagation delay vs C_L .

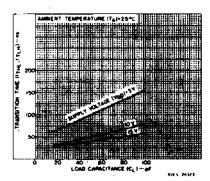


Fig. 13 - Typical transition time vs. load capacitance.

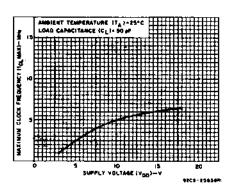


Fig. 15 — Typical meximum-clock-frequency vs. supply voltage.

DYNAMIC ELECTRICAL CHARACTERISTICS

At T_A =25°C; Input t_F , t_f = 20 ns, C_L = 50 pF, R_L = 200 k Ω

CHARACTERISTIC	VDD		UNITS		
	(V)	MIN.	TYP.	MAX.	0
Propagation Delay Time,		1	1	1	
tPHL, tPLH	5		300	coo	<u> </u>
Clock to Social Output O.	10	-	125	600 250	
Clock to Serial Output Q _S	15	_	95	190	ns
	5		230	460	
Clock to Serial Output Q'S	10	_	110	220	l ns
Sister to serial parper 45	15	-	75	150	,,,
	5		420	840	
Clock to Parallel Output	10	l <u>-</u>	195	390	ns
Clock to Paramer Output	15	_	135	270	
	5		290	580	
Strobe to Parallel Output	10	_	145	290	ns
	15		100	200	
Output Enable to Parallel	5	_	140	280	
Output:	10	_	60	120	ns
t _{PHZ} , t _{PZH}	15	_	45	90	
	5	_	100	200	
tPLZ. tPZL	10	_	50	100	ns
	15		40	80	
Minimum Strobe Pulse .	5	_	100	200	
Width, tw	10	-	. 40	80	ns
	15	_	35	70	
Minimum Clock Pulse	5	_	100	200	-
Width, tw	10	-	50	100	ΠS
	15	-	40	83	
Minimum Data Setup	5	-	60	125	
Time, ts	10	-	30	55	ns
	15		20	35	
Transition Time:	5	-	100	200	
THL. TLH	10	-	50	100	D\$
	15	_	40	80	
Maximum Clock Input Rise	5 10	15 5			
or Fall Time, t _f CL, t _f CL	15	_ 5		-	μς
Maximum Clock Input	5	1.25	2.5		
Frequency, for	10	2.5	5		MHz
	15	3	6		
Input Capacitance C _{IN}	l _	l _	5	7.5	pF
(Any Input)	1	:	"		þΓ

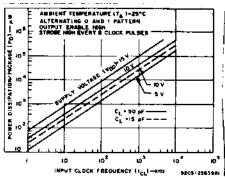


Fig. 16 – Dynamic power dissipation vs input clock frequency.

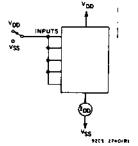


Fig. 17 — Quiescent device current test circuit.

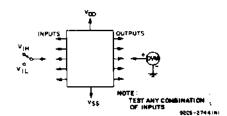


Fig. 18 - Input voltage test circuit.

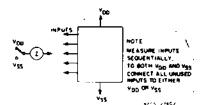
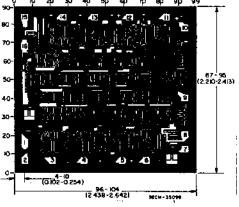


Fig. 19 - Input current test circuit.



Dimensions and Pad Layout for CD4094B Chip.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils $(10^{-3} \, \text{inch})$.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing		Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
7702501EA	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	7702501EA CD4094BF3A	Samples
CD4094BE	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4094BE	Samples
CD4094BEE4	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4094BE	Samples
CD4094BF	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4094BF	Samples
CD4094BF3A	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	7702501EA CD4094BF3A	Samples
CD4094BNSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4094B	Samples
CD4094BPW	ACTIVE	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM094B	Samples
CD4094BPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM094B	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

PACKAGE OPTION ADDENDUM

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(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD4094B, CD4094B-MIL:

Catalog: CD4094B

Military: CD4094B-MIL

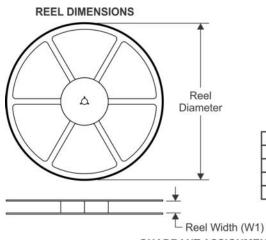
NOTE: Qualified Version Definitions:

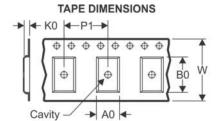
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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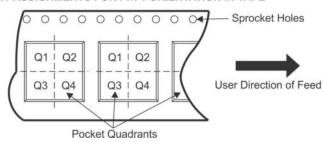
TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

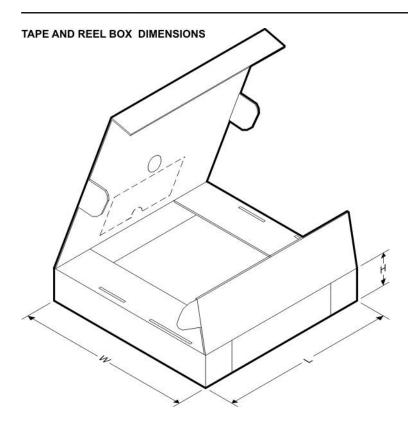


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4094BNSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4094BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

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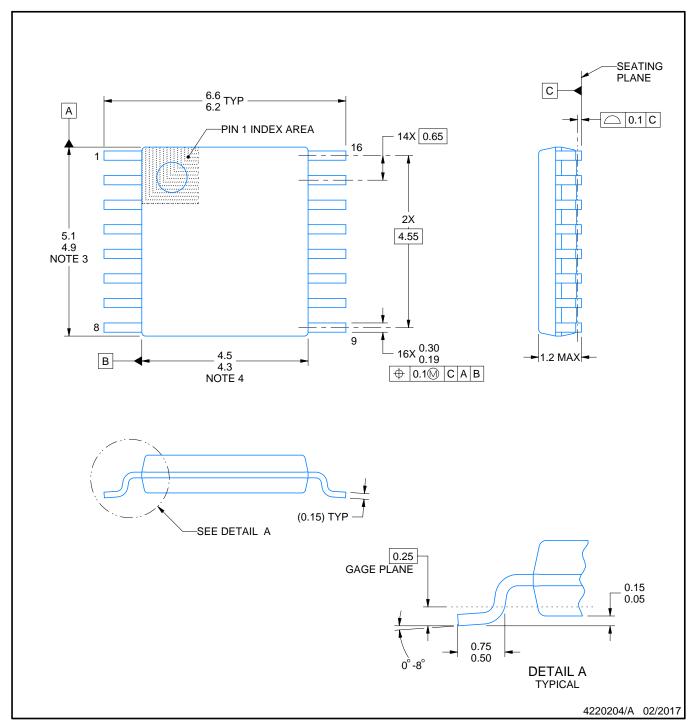


*All dimensions are nominal

Device	Package Type	Package Type Package Drawing		ge Type Package Drawing Pir		SPQ	Length (mm)	Width (mm)	Height (mm)
CD4094BNSR	SO	NS	16	2000	367.0	367.0	38.0		
CD4094BPWR	TSSOP	PW	16	2000	853.0	449.0	35.0		



SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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